

FDMS7660-VB Datasheet P-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A)	Q _g (Typ.)		
- 30	0.0032 at V _{GS} = - 10 V	- 100	78 nC		
	0.0050 at V _{GS} = - 4.5 V	- 80	70110		

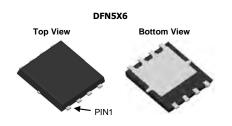
FEATURES

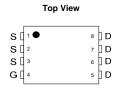
- Halogen-free
- Trench Power MOSFET
- 100 % R_g Tested

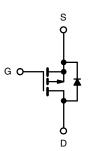


APPLICATIONS

- Notebook
 - Load Switch







P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS	S T _A = 25 °C, unles	ss otherwise not	ed		
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	VDS	- 30	V		
Gate-Source Voltage	V_{GS}	± 20	V		
	$T_C = 25 ^{\circ}\text{C}$ $T_C = 70 ^{\circ}\text{C}$		- 100 		
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	- 75 - 31.6 ^{b, c}		
	T _A = 70 °C		- 25.3 ^{b, c}	A	
Pulsed Drain Current		I _{DM}	- 300		
Continuous Source-Drain Diode Current	T _C = 25 °C	I _S	- 60 ^a		
Commission Course Brain Blode Carrent	T _A = 25 °C	.8	- 5.6 ^{b, c}		
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	- 40		
Single Pulse Avalanche Energy		E _{AS}	80	mJ	
	T _C = 25 °C		104		
Maximum Power Dissipation	T _C = 70 °C	P _D	66.6	w	
Maximum rower Dissipation	T _A = 25 °C	, р	6.25 ^{b, c}	• • • • • • • • • • • • • • • • • • • •	
	T _A = 70 °C		4.0 ^{b, c}	7	
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 150	°C		
Soldering Recommendations (Peak Temperature		260			

THERMAL RESISTANCE RATINGS						
Parameter	Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient ^{b, f}	t ≤ 10 s	R _{thJA}	15	20	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	0.9	1.2		

Notes:

- a. Package limited.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s
- d. The DFN5x6 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under Steady State conditions is 54 °C/W.

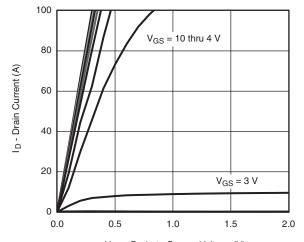


Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static				, ,			
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 30			V	
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J	J 050 A		- 31		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = - 250 μA		6.5			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 1.0		- 3.0	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 30 V, V _{GS} = 0 V			- 1		
		$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			- 10	μΑ	
On-State Drain Current ^a	I _{D(on)}	V _{DS} = - 5 V, V _{GS} = - 10 V	- 30			Α	
	Б	V _{GS} = - 10 V, I _D = - 20 A		0.0032		Ω	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 4.5 V, I _D = - 15 A		0.005			
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 15 V, I _D = - 20 A		95		S	
Dynamic ^b							
Input Capacitance	C _{iss}			8650			
Output Capacitance	C _{oss}	V _{DS} = - 15 V, V _{GS} = 0 V, f = 1 MHz		1215		pF	
Reverse Transfer Capacitance	C _{rss}			1125			
		V _{DS} = - 15 V, V _{GS} = - 10 V, I _D = - 20 A		167	250	nC	
Total Gate Charge	Q_g			78	120		
Gate-Source Charge	Q_{gs}	$V_{DS} = -15 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -20 \text{ A}$		27			
Gate-Drain Charge	Q_{gd}			35			
Gate Resistance	R_{g}	f = 1 MHz		1.7		Ω	
Turn-On Delay Time	t _{d(on)}			25	40		
Rise Time	t _r	V_{DD} = - 15 V, R_L = 15 Ω		15	30	ns	
Turn-Off Delay Time	t _{d(off)}	$I_D\cong$ - 1.0 A, V_{GEN} = - 10 V, R_g = 1 Ω		110	170		
Fall Time	t _f			30	50		
Turn-On Delay Time	t _{d(on)}			110	170		
Rise Time	t _r	V_{DD} = - 15 V, R_L = 15 Ω		100	150		
Turn-Off Delay Time	t _{d(off)}	$I_D\cong$ - 1.0 A, $V_{GEN}=$ - 4.5 V, $R_g=$ 1 Ω		100	150		
Fall Time	t _f			50	75		
Drain-Source Body Diode Characteristi	cs			"			
Continuous Source-Drain Diode Current	I _S	$T_C = 25 ^{\circ}C$			60	٨	
Pulse Diode Forward Current ^a	I _{SM}				100	A	
Body Diode Voltage	V _{SD}	I _S = - 5 A		- 0.74	- 1.1	V	
Body Diode Reverse Recovery Time	t _{rr}			50	100	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 3.5 A, dl/dt = 100 A/μs, T _J = 25 °C		65	130	nC	
Reverse Recovery Fall Time	t _a			26			
Reverse Recovery Rise Time	t _b			24		ns	

- a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing.

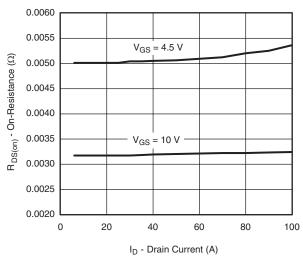
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



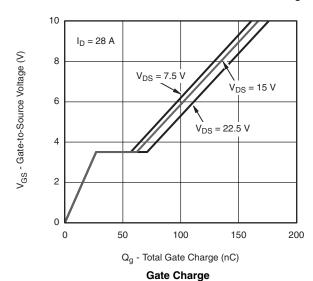


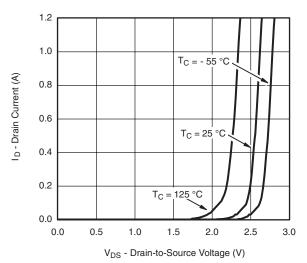
V_{DS} - Drain-to-Source Voltage (V)

Output Characteristics

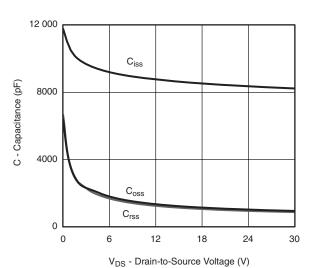


On-Resistance vs. Drain Current and Gate Voltage

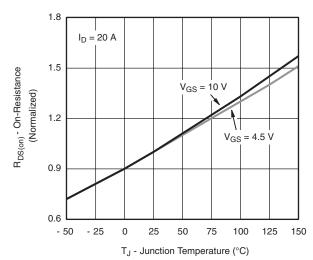




Transfer Characteristics

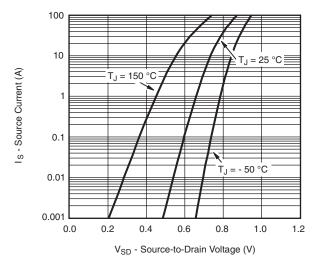


Capacitance

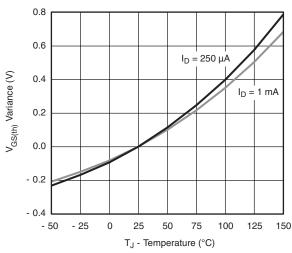


On-Resistance vs. Junction Temperature



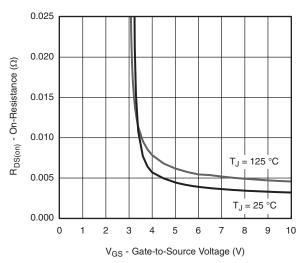


Source-Drain Diode Forward Voltage

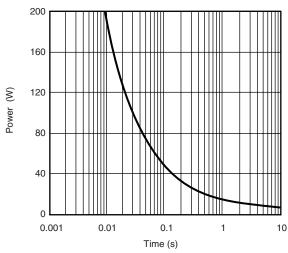


Threshold Voltage

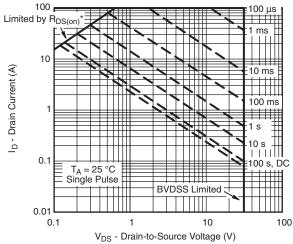
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On-Resistance vs. Gate-to-Source Voltage



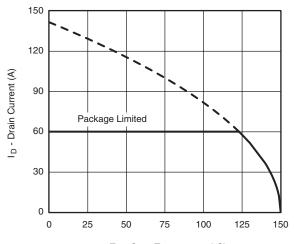
Single Pulse Power, Junction-to-Ambient



* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

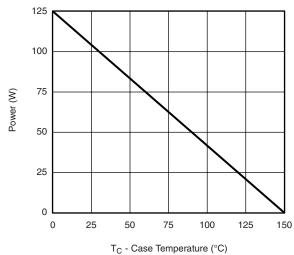
Safe Operating Area, Junction-to-Ambient

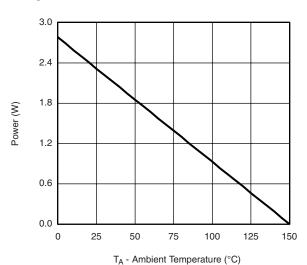




 $T_{\mbox{\scriptsize C}}$ - Case Temperature (°C)

Current Derating*

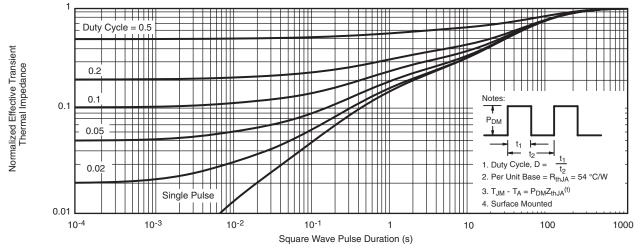




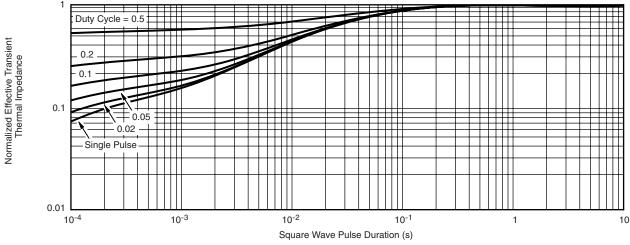
Power, Junction-to-Case Power, Junction-to-Ambient

^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



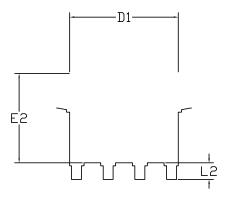


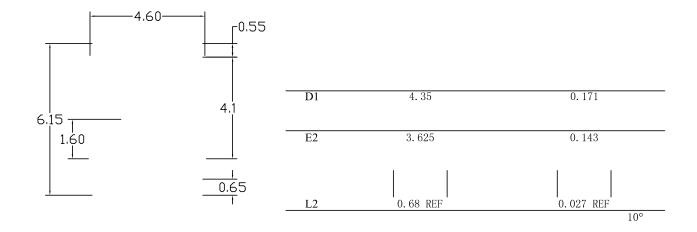
Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

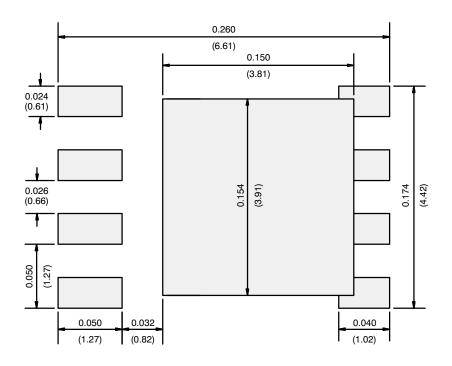








RECOMMENDED MINIMUM PADS FOR DFN5 x 6



Recommended Minimum Pads Dimensions in Inches/(mm)



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